

Cross-sectioning After Thermal Cycle Test

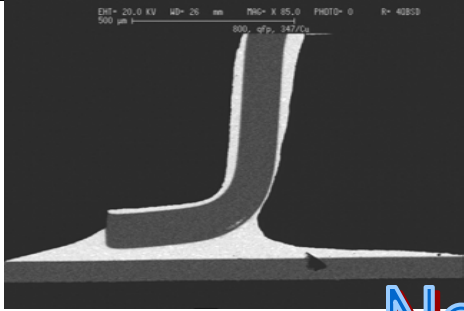
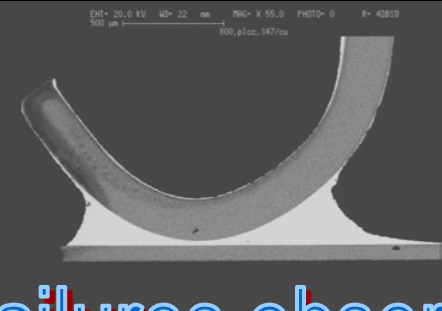
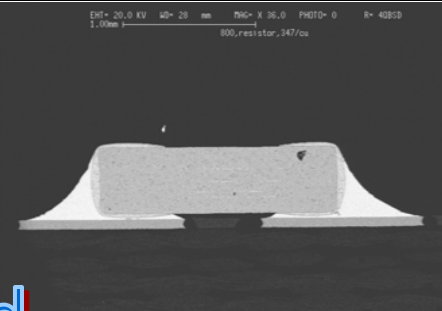
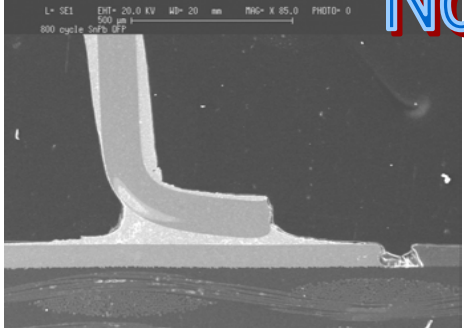
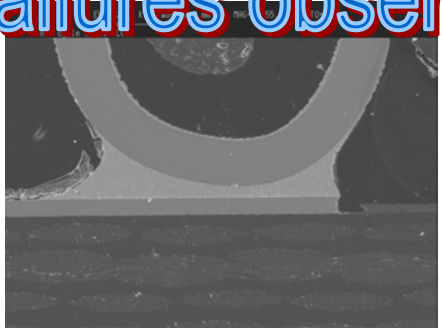
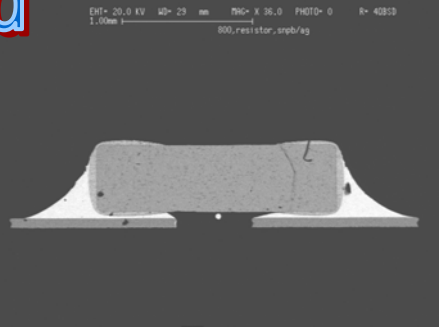
Condition (JESD22-A104-B, Test condition G)

Temperature: -40°C to +125°C

Dwell time: 15 minutes

Number of cycles: 800

Frequency: 1 cycle / hr.

	QFP (p0.5)	PLCC (J-Lead)	Chip capacitor (0805)
Viromet Series			
SnPb			

No Failures observed